



Corrigendum: Transcription rate strongly affects splicing fidelity and cotranscriptionality in budding yeast

Vahid Aslanzadeh, Yuanhua Huang, Guido Sanguinetti, et al.

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Corrigenda

Genome Research 27: 757–767 (2017)

Corrigendum: Direct determination of diploid genome sequences

Neil I. Weisenfeld, Vijay Kumar, Preyas Shah, Deanna M. Church, and David B. Jaffe

The authors would like to correct the omission of Supplemental Notes, which was inadvertently excluded from the initial publication of this article. Please note that the Supplemental Notes have now been published online in the Revised Supplemental Material. The authors apologize for the inconvenience.

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Genome Research 28: 203–213 (2018)

Corrigendum: Transcription rate strongly affects splicing fidelity and cotranscriptionality in budding yeast

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The authors would like to correct errors in Figures 2, 4, and Supplemental Figure S3, which were inadvertently mislabeled in the initial publication of this article. In Figure 2C, the y -axis should read SEF (Log_{10}). Similarly, in Figure 4, panels A, B, D, E, F, and H (both x - and y -axes) and Supplemental Figure S3, Log_2 should be corrected to Log_{10} . This error underrepresents the differences in the data. Please note that the revised panels have now been published online with their respective figures and in the Revised Supplemental Material. The authors apologize for the inconvenience.

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